PD-95769

International

- Advanced Process Technology
- Surface Mount (IRF9Z34NS)
- Low-profile through-hole (IRF9Z34NL)
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead-Free

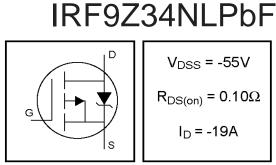
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

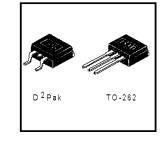
The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRF9Z34NL) is available for lowprofile applications.

Absolute Maximum Ratings



IRF9Z34NSPbF



	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V ^⑤	-19	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V ^⑤	-14	A
I _{DM}	Pulsed Drain Current ①⑤	-68	
P _D @T _A =25°C	Power Dissipation	3.8	W
P _D @T _C =25°C	Power Dissipation	68	W
	Linear Derating Factor	0.45	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy 25	180	mJ
AR	Avalanche Current [®]	-10	A
E _{AR}	Repetitive Avalanche Energy①	6.8	mJ
d∨/dt	Peak Diode Recovery dv/dt 35	-5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
Rejc	Junction-to-Case		2.2	0000
R _{eja}	Junction-to-Ambient (PCB Mounted,steady-state)**		40	°CW

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_D = -250\mu A$	
ΔV(BR)DSS/ΔTJ	Breakdown Voltage Temp. Coefficient		-0.05		V/°C	Reference to 25°C, $I_D = -1$ mA \odot	
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.10	Ω	V _{GS} = -10V, I _D = -10A ④	
VGS(th)	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
g fs	Forward Transconductance	4.2	s <u></u>		S	V _{DS} = -25V, I _D = -10A ⁽	
1	Drain-to-Source Leakage Current		2 <u></u> 2	-25	μA	$V_{DS} = -55V, V_{GS} = 0V$	
DSS	Dialit-to-Source Leakage Current			-250	μΑ	$V_{DS} = -44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$	
I _{GSS}	Gate-to-Source Forward Leakage			100		V _{GS} = 20V	
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V	
Qg	Total Gate Charge			35		I _D = -10A	
Q _{gs}	Gate-to-Source Charge			7.9	nC	V _{DS} = -44V	
Q _{gd}	Gate-to-Drain ("Miller") Charge			16		V _{GS} = -10V, See Fig. 6 and 13 ④⑤	
t _{d(on)}	Turn-On Delay Time		13			V _{DD} = -28V	
tr	RiseTime		55			I _D = -10A	
t _{d(off)}	Turn-Off Delay Time		30		ns	R _G = 13Ω R _D = 2.6Ω, See Fig. 10 ④	
t _f	Fall Time		41				
L _S	Internal Source Inductance		7.5	_	nH	Between lead, and center of die contact	
Ciss	Input Capacitance		620	-		V _{GS} = 0V	
Coss	Output Capacitance		280		pF	V _{DS} = -25V	
Crss	Reverse Transfer Capacitance		140			f = 1.0MHz, See Fig. 5⑤	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current (Body Diode)			-19	A	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			-68		integral reverse p-n junction diode.
VSD	Diode Forward Voltage			-1.6	V	$T_{J} = 25^{\circ}C, I_{S} = -10A, V_{GS} = 0V $
t _{rr}	Reverse Recovery Time		54	82	ns	TJ = 25°C, I⊧ = -10A
Qrr	Reverse Recovery Charge		110	160	nC	di/dt = -100A/µs ⊕⑤
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11) ④ Pulse width \leq 300µs; duty cycle \leq 2%.

② Starting $T_J = 25^{\circ}C$, L = 3.6mH

⑤ Uses IRF9Z34N data and test conditions

 R_{G} = 25 Ω , I_{AS} = -10A. (See Figure 12)

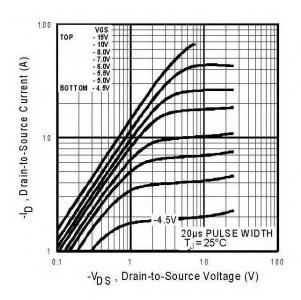
 $\label{eq:ISD} \textcircled{3} I_{\text{SD}} \leq \textbf{-10A}, \ \textbf{di/dt} \leq \textbf{-290A/\mus}, \ V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}},$ $T_J \leq 175^\circ C$

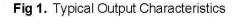
** When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.

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IRF9Z34NS/LPbF





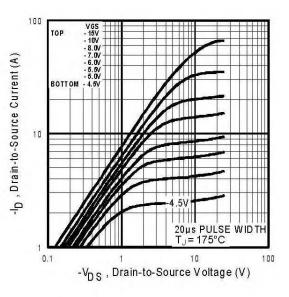


Fig 2. Typical Output Characteristics

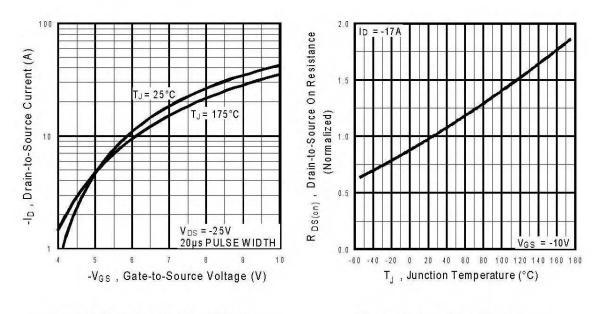




Fig 4. Normalized On-Resistance Vs. Temperature



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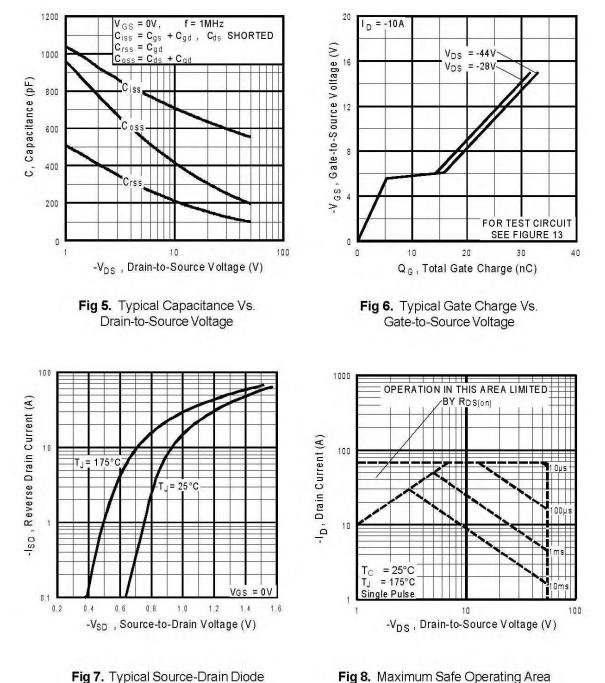


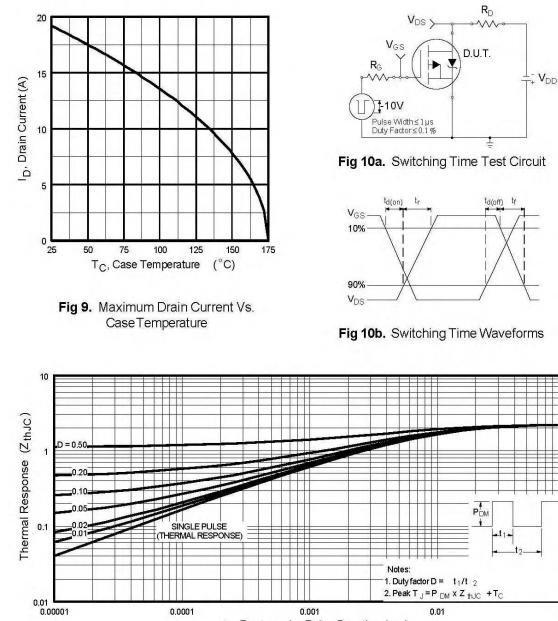
Fig 8. Maximum Safe Operating Area

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Forward Voltage

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IRF9Z34NS/LPbF



t₁ , Rectangular Pulse Duration (sec)

Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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0.1

International

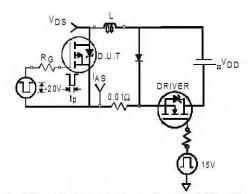


Fig 12a. Unclamped Inductive Test Circuit

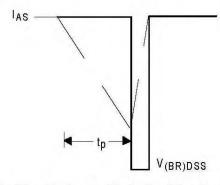


Fig 12b. Unclamped Inductive Waveforms

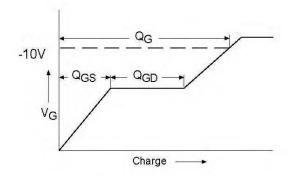


Fig 13a. Basic Gate Charge Waveform

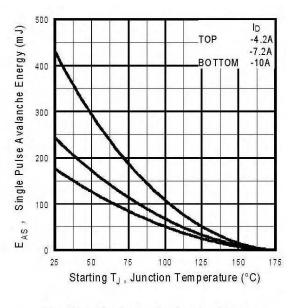


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

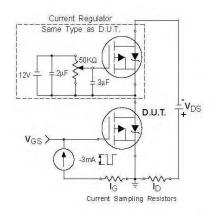
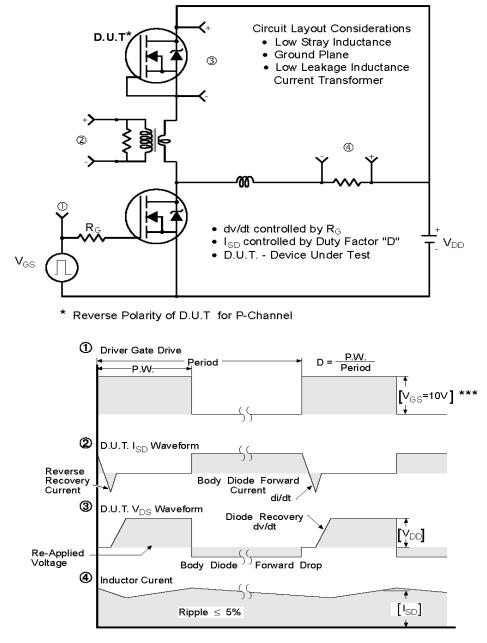


Fig 13b. Gate Charge Test Circuit

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IRF9Z34NS/LPbF

Peak Diode Recovery dv/dt Test Circuit



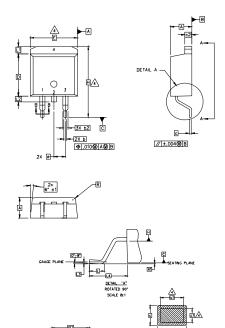
*** $V_{\rm GS}$ = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

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D^2Pak Package Outline (Dimensions are shown in millimeters (inches)

NOTES:



	I. DIMENSIONING AND TULERANGING PER ASME 114.3M-1994										
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].											
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.											
A. DIMENSION 61 AND C1 APPLY TO BASE METAL ONLY.											
	5. CONTROLLING DIMENSION: INCH.										
S.		2.110 2.111				1					
Ý		DIMEN	SIONS		N						
M B				HES	1 P						
0	MIN.	MAX.	MIN.	MAX.	Ē						
A	4.06	4,83	,160	.190							
A1	0.00	0.254	.000	.010							
ь	0.51	0.99	.020	.039							
b1	0.51	0.89	.020	.035	4						
b2	1,14	1,78	.045	.070		LEAD ASSIGNMENTS					
с	0,38	0.74	.015	.029							
c1	0.38	0.58	.015	.023	4	HEXFET					
c2	1.14	1.65	.045	.065		1 GATE					
D	8.51	9.65	.335	.380	3	2, 4 DRAIN					
D1	6,86		.270			3 SOURCE					
Е	9.65	10.67	.380	.420	3						
E1	6.22		.245								
e	2.54 BSC .100 BSC			IGBTS. COPACK							
н	14.61	15.88	.575	.625		4 0475					
L	1.78	2.79	.070	.110		1 GATE 2. 4 COLLECTOR					
L1		1.65		.065		3 EMITTER					
L2	1.27	1.78	.050	.070							
L3	0.25	BSC	.010	BSC							
L4	4.78	5.28	.188	.208		DIODES					
m	17,78		.700			DIODES					
m1	8.89		.350			1 ANODE *					
n	11.43		.450			2, 4.– CATHODE 3.– ANODE					
0	2.08 3.81		.082			S. ANODE					
P R	0.51	0.71	.150	0.00		* PART DEPENDENT.					
		0,71		.028 93*		PART DEPENDENT.					
θ	90.	93*	90.	93							
						3					

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

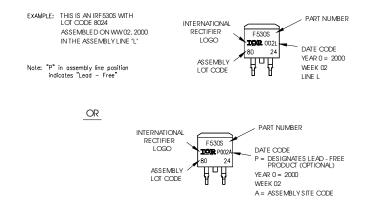
LEAD ASSIGNMENTS

DIODES 1.- ANODE * 2. 4.- CATHODE 3.- ANODE

D²Pak Part Marking Information

-E1 VEW A-A SECTION B-B

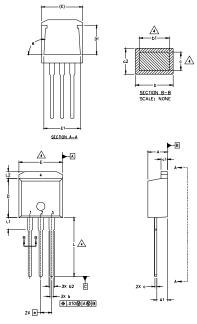
SCALE 2:1



International **ICR** Rectifier

IRF9Z34NS/LPbF

TO-262 Package Outline (Dimensions are shown in millimeters (inches)



S Y M	DIMENSIONS							
B	MILLIM	ETERS	INC	O T E S				
B O L	MIN.	MAX.	MIN.	MAX.	L S			
А	4.06	4.83	.160	.190				
A1	2.03	2.92	.080	.115				
b	0.51	0.99	.020	.039				
b1	0.51	0.89	.020	.035	4			
b2	1.14	1.40	.045	.055				
С	0.38	0.63	.015	.025	4			
c1	1.14	1.40	.045	.055				
c2	0.43	.063	.017	.029				
D	8.51	9.65	.335	.380	3			
D1	5.33		.210					
Е	9.65	10.67	.380	.420	3			
E1	6.22	6.22						
е	2.54 BSC		.100 BSC					
L	13,46	14.09	.530	.555				
L1	3.56	3.71	.140	.146				
L2		1.65		.065				

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE

2.- DRAIN

4.- DRAIN

3.- SOURCE

<u>IGBT</u>

2 - COLLECTOR

3 - EMITTER

1 - GATE

(_____

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

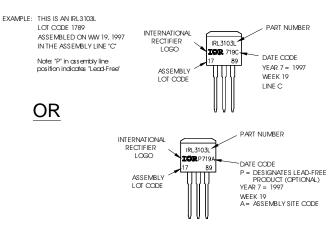
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3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

A. DIMENSION 61 AND C1 APPLY TO BASE METAL ONLY.

5. CONTROLLING DIMENSION: INCH.

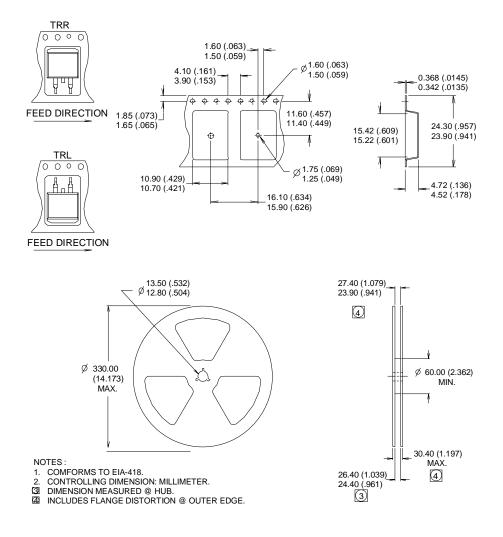
TO-262 Part Marking Information



International **ICR** Rectifier

D²Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



Data and specifications subject to change without notice.

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